electrical characteristics at 25°C case temperature

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$V_{(BR)CBO}$	Collector-base breakdown voltage	I_C = 1 mA	I_E = 0	TIP150	300			V
				TIP151	350			
				TIP152	400			
$V_{(BR)CEO}$	Collector-emitter breakdown voltage	I_C = 10 mA (see Note 4)	I_B = 0	TIP150	300			V
				TIP151	350			
				TIP152	400			
I_{CEO}	Collector-emitter cut-off current	V_{CE} = 300 V	I_B = 0	TIP150			250	µA
		V_{CE} = 350 V	I_B = 0	TIP151			250	
		V_{CE} = 400 V	I_B = 0	TIP152			250	
$I_{CEX(sus)}$	Collector-emitter sustaining current	$V_{CLAMP} = V_{(BR)CEO}$			7			A
I_{EBO}	Emitter cut-off current	V_{EB} = 8 V	I_C = 0				15	mA
h_{FE}	Forward current transfer ratio	V_{CE} = 5 V	I_C = 2.5 A		150			
		V_{CE} = 5 V	I_C = 5A	(see Notes 4 and 5)	50			
		V_{CE} = 5 V	I_C = 7 A		15			
$V_{CE(sat)}$	Collector-emitter saturation voltage	I_B = 10 mA	I_C = 1 A				1.5	V
		I_B = 100 mA	I_C = 2 A	(see Notes 4 and 5)			1.5	
		I_B = 250 mA	I_C = 5 A				2	
$V_{BE(sat)}$	Base-emitter saturation voltage	I_B = 100 mA	I_C = 2 A				2.2	V
		I_B = 250 mA	I_C = 5 A	(see Notes 4 and 5)			2.3	
V_{EC}	Parallel diode forward voltage	I_E = 7 A	I_B = 0	(see Notes 4 and 5)			3.5	V
h_{fe}	Small signal forward current transfer ratio	V_{CE} = 5 V	I_C = 0.5 A	f = 1 kHz	200			
$\|h_{fe}\|$	Small signal forward current transfer ratio	V_{CE} = 5 V	I_C = 0.5 A	f = 1 MHz	10			
C_{ob}	Output capacitance	V_{CB} = 10 V	I_E = 0	f = 1 MHz			100	pF

NOTES: 4. These parameters must be measured using pulse techniques, t_p = 300 µs, duty cycle ≤ 2%.
5. These parameters must be measured using voltage-sensing contacts, separate from the current carrying contacts.

thermal characteristics

PARAMETER		MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to case thermal resistance			1.56	°C/W
$R_{\theta JA}$	Junction to free air thermal resistance			62.5	°C/W
$C_{\theta C}$	Thermal capacitance of case		0.9		J/°C

inductive-load-switching characteristics at 25°C case temperature

PARAMETER		TEST CONDITIONS †			MIN	TYP	MAX	UNIT
t_{sv}	Voltage storage time	I_C = 5 A $V_{(clamp)} = V_{(BR)CEO}$	$I_{B(on)}$ = 250 mA	R_{BE} = 47 Ω		3.9		µs
t_{si}	Current storage time					4.7		µs
t_{rv}	Voltage transition time					1.2		µs
t_{ti}	Current transition time					1.2		µs
t_{xo}	Cross-over time					2.0		µs

† Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.

PARAMETER MEASUREMENT INFORMATION

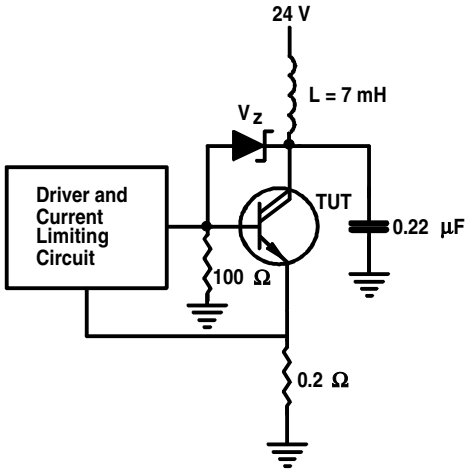

Figure 1. Functional Test Circuit

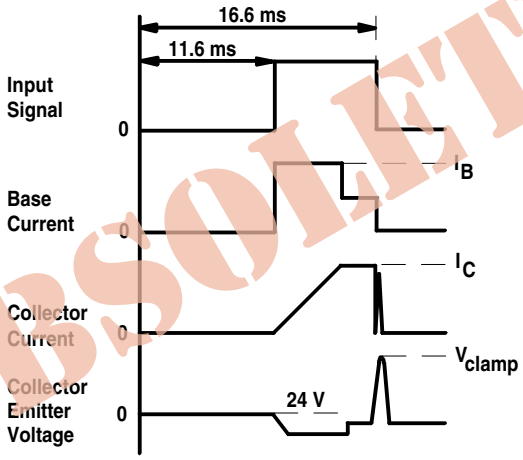

Figure 2. Functional Test Waveforms

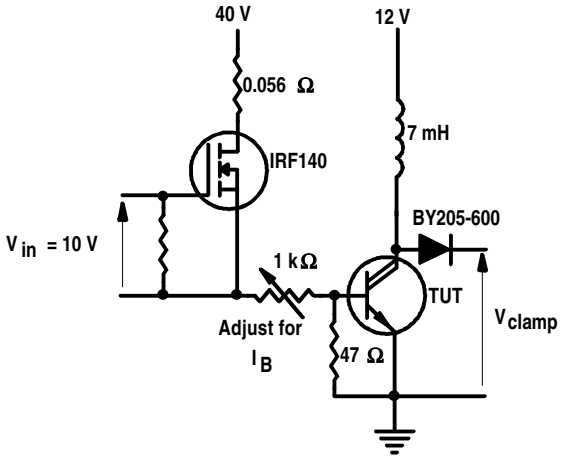

Figure 3. Switching Test Circuit

TYPICAL CHARACTERISTICS

TYPICAL DC CURRENT GAIN vs COLLECTOR CURRENT

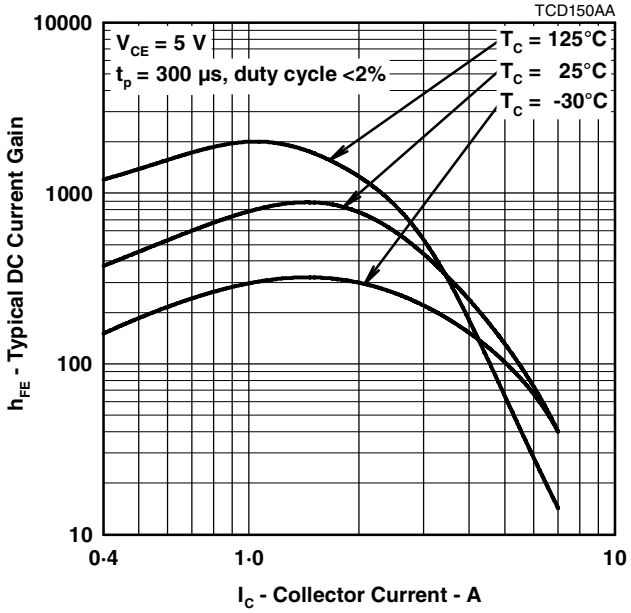

Figure 4.

COLLECTOR-EMITTER SATURATION VOLTAGE vs COLLECTOR CURRENT

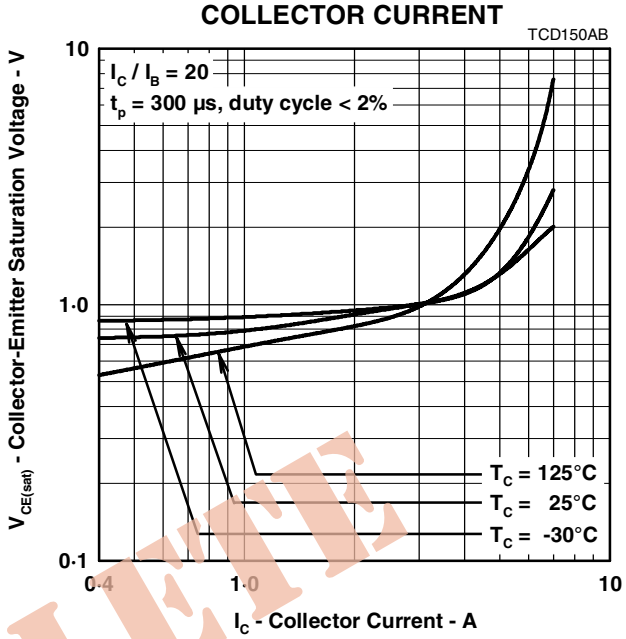

Figure 5.

BASE-EMITTER SATURATION VOLTAGE vs COLLECTOR CURRENT

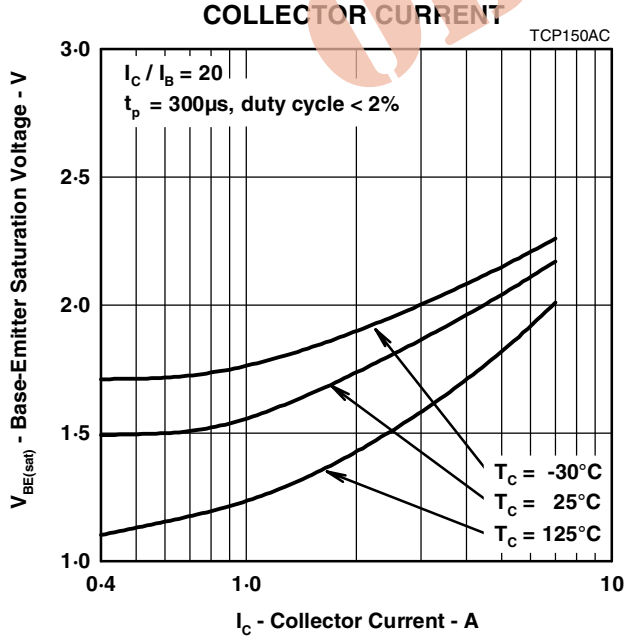

Figure 6.

COLLECTOR CUT-OFF CURRENT vs CASE TEMPERATURE

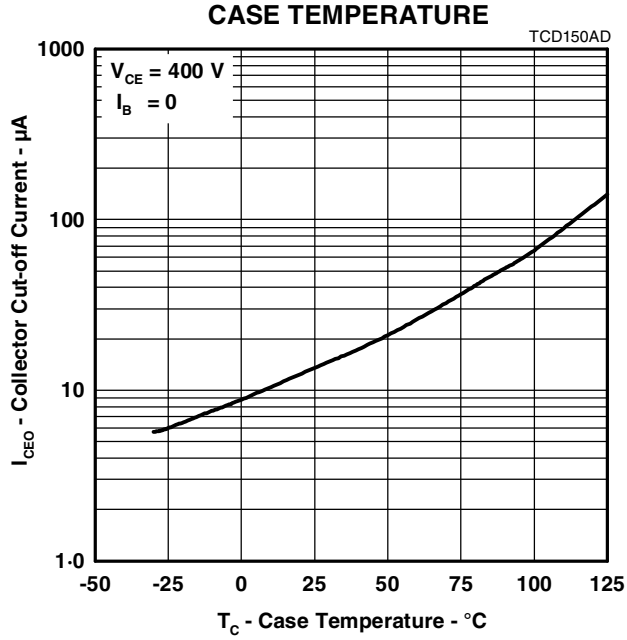

Figure 7.

BOURNS®

MAXIMUM SAFE OPERATING REGIONS

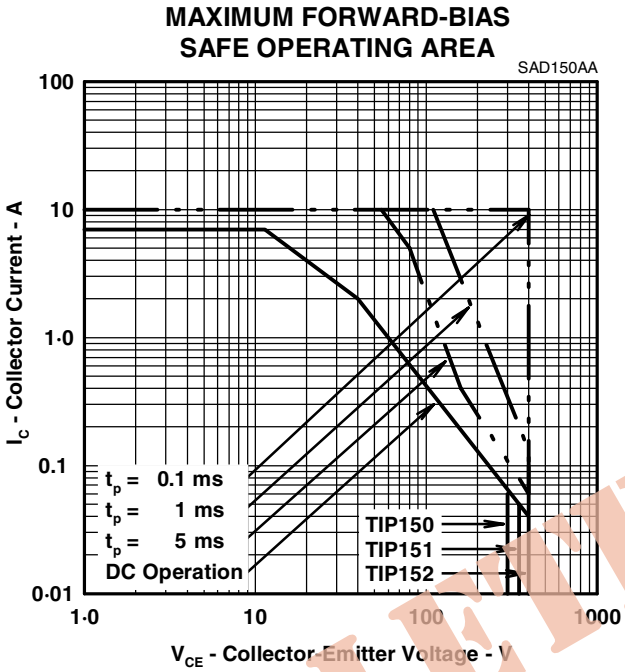

Figure 8.

THERMAL INFORMATION

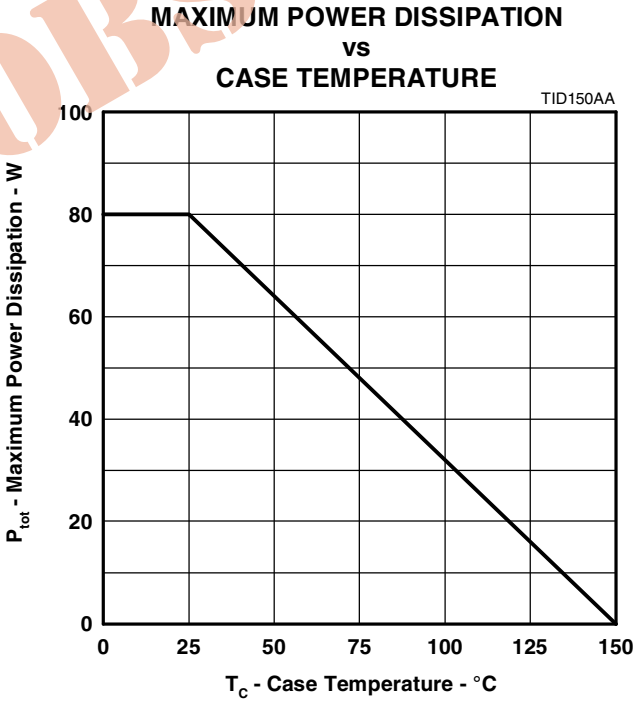

Figure 9.